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### **1** General description

The BGS8L2, also known as the LTE3001L, is a Low-Noise Amplifier (LNA) with bypass switch for LTE receiver applications, available in a small plastic 6-pin extremely thin leadless package. The BGS8L2 requires one external matching inductor.

The BGS8L2 delivers system-optimized gain for both primary and diversity applications where sensitivity improvement is required. The high linearity of these low noise devices ensures the required receive sensitivity independent of cellular transmit power level in FDD (Frequency Division Duplex) systems. When receive signal strength is sufficient, the BGS8L2 can be switched off to operate in bypass mode at a 1  $\mu$ A current, to lower power consumption.

The BGS8L2 can also be used in Digital TV receivers in the frequency range 460 MHz - 740 MHz.

The BGS8L2 is optimized for 460 MHz to 960 MHz.

### 2 Features and benefits

- · Operating frequency from 460 MHz to 960 MHz
- Noise figure = 0.85 dB
- Gain 13 dB
- High input 1 dB compression point of -1 dBm
- Bypass switch insertion loss of 1.9 dB
- IP3<sub>i</sub> of 1.5 dBm
- Supply voltage 1.5 V to 3.1 V
- · Self-shielding package concept
- Integrated supply decoupling capacitor
- Optimized performance at a supply current of 5.2 mA @ 2.8 V
- Power-down mode current consumption < 1 µA
- Integrated temperature stabilized bias for easy design
- · Requires only one input matching inductor
- · Input and output DC decoupled
- ESD protection on all pins (HBM > 2 kV)
- · Integrated matching for the output
- Available in 6-pins leadless package 1.1 mm × 0.7 mm × 0.37 mm; 0.4 mm pitch: SOT1232
- 180 GHz transit frequency SiGe:C technology
- Moisture sensitivity level 1



## **3** Applications

- LNA for LTE reception in smart phones
- Feature phones
- Tablet PCs
- RF front-end modules
- Digital TV receivers

## 4 Quick reference data

#### Table 1. Quick reference data

 $f = 882 \text{ MHz}; V_{CC} = 2.8 \text{ V}; V_{I(CTRL)} \ge 0.8 \text{ V}; T_{amb} = 25 \text{ °C}; input matched to 50 \Omega using a 8.2 nH inductor; unless otherwise specified.}$ 

Symbol	Parameter	Conditions		Min	Тур	Мах	Unit
V <sub>CC</sub>	supply voltage			1.5	-	3.1	V
I <sub>CC</sub>	supply current	in gain mode		-	5.2	-	mA
		in bypass mode		-	-	1	μA
G <sub>p</sub>	power gain	in gain mode	[1]	-	13.0	-	dB
		in bypass mode	[1]	-	-1.9	-	dB
NF	noise figure		[1][2]	-	0.85	-	dB
P <sub>i(1dB)</sub>	input power at 1 dB gain compression		[1]	-	-1.0	-	dBm
IP3 <sub>i</sub>	input third-order intercept point		[1]	-	1.5	-	dBm

[1] E-UTRA operating band 5 (869 MHz to 894 MHz).

[2] PCB losses are subtracted.

## 5 Ordering information

#### Table 2. Ordering information

Type number	Package						
	Name	Description	Version				
BGS8L2	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body 1.1 × 0.7 × 0.37 mm	SOT1232				
OM17005	EVB	BGS8L2 evaluation board	-				

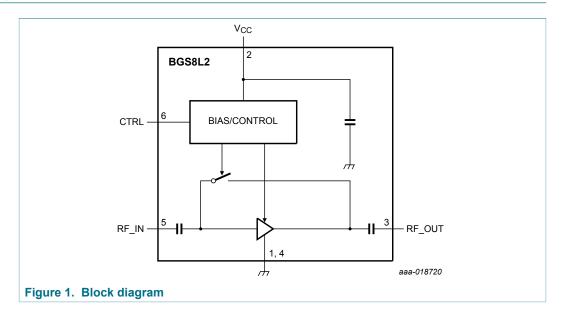
## 6 Marking

Table 3. Marking codes	
Type number	Marking code
BGS8L2	Μ

## BGS8L2

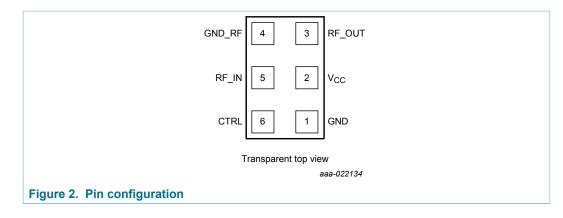
SiGe:C Low-noise amplifier MMIC with bypass switch for LTE

## 7 Block diagram



## 8 Pinning information

## 8.1 Pinning



### 8.2 Pin description

Table 4. Pinning		
Symbol	Pin	Description
GND	1	ground
V <sub>CC</sub>	2	supply voltage
RF_OUT	3	RF out
GND_RF	4	ground RF
RF_IN	5	RF in
CTRL	6	gain control, switch between gain and bypass mode

#### **Limiting values** 9

#### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). See section 18.3 "Disclaimers", paragraph "Limiting values".

Symbol	Parameter	Conditions		Min	Max	Unit
V <sub>CC</sub>	supply voltage	RF input AC coupled		-0.5	+5.0	V
V <sub>I(CTRL)</sub>	input voltage on pin CTRL	$V_{I(CTRL)} < V_{CC} + 0.6 V$	[1] [2]		+5.0	V
V <sub>I(RF_IN)</sub>	input voltage on pin RF_IN	DC, $V_{I(RF_{IN})} < V_{CC} + 0.6 V$	[1] [2]		+5.0	V
V <sub>I(RF_OUT)</sub>	input voltage on pin RF_OUT	DC, $V_{I(RF_{OUT})} < V_{CC} + 0.6 V$	[1] [2] [3]	-0.5	+5.0	V
Pi	input power		[1]	-	26	dBm
P <sub>tot</sub>	total power dissipation	T <sub>sp</sub> ≤ 130 °C		-	55	mW
T <sub>stg</sub>	storage temperature			-65	+150	°C
Tj	junction temperature			-	150	°C
V <sub>ESD</sub>	electrostatic discharge voltage	Human Body Model (HBM) According to ANSI/ESDA/JEDEC standard JS-001		-	±2	kV
		Charged Device Model (CDM) According to JEDEC standard JESD22-C101C		-	±1	kV

[1]

Stresses with pulses of 1 s in duration.  $V_{CC}$  connected to a power supply of 2.8 V with 500 mA current limit. Warning: Due to internal ESD diode protection, to avoid excess current, the applied DC voltage must not exceed  $V_{CC}$  + 0.6 V or 5.0 V. The RF input and RF output are AC coupled through internal DC blocking capacitors. [2] [3]

## **10** Recommended operating conditions

#### Table 6. Operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>CC</sub>	supply voltage		1.5	-	3.1	V
T <sub>amb</sub>	ambient temperature		-40	+25	+85	°C
V <sub>I(CTRL)</sub>	input voltage on pin CTRL	OFF state	-	-	0.3	V
		ON state	0.8	-	V <sub>CC</sub>	V

## **11** Thermal characteristics

Table 7. Therr	nal characteristics			
Symbol	Parameter	Conditions	Тур	Unit
R <sub>th(j-sp)</sub>		thermal resistance from junction to solder point	225	K/W

## **12 Characteristics**

#### Table 8. Characteristics at $V_{CC}$ = 1.8 V

460 MHz  $\leq f \leq$  960 MHz,  $V_{CC} = 1.8$  V,  $V_{I(CTRL)} \geq 0.8$  V and  $T_{amb} = 25$  °C. Input matched to 50  $\Omega$  using application diagram figure 3 and component values as in table 10. Unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Gain mod	e						
I <sub>CC</sub>	supply current			3.0	5.0	7.0	mA
G <sub>p</sub>	power gain	f = 470 MHz, L1 = 18 nH	[1]	11.5	13.5	15.5	dB
		f = 650 MHz, L1 = 18 nH	[1]	12.5	14.5	16.5	dB
	f = 740 MHz, L1 = 18 nH <sup>[1]</sup> f = 740 MHz, L1 = 8.2 nH <sup>[1] [2]</sup>	f = 740 MHz, L1 = 18 nH		12.0	14.0	16.0	dB
		11.5	13.5	15.5	dB		
		f = 882 MHz, L1 = 8.2 nH		11.0	13.0	15.0	dB
		f = 943 MHz, L1 = 8.2 nH	[1] [4]	10.5	12.5	14.5	dB
RL <sub>in</sub>	input return loss	f = 470 MHz, L1 = 18 nH	[5]	-	4.5	-	dB
		f = 650 MHz, L1 = 18 nH		-	12	-	dB
		f = 740 MHz, L1 = 18 nH	[2]	-	10.5	-	dB
		f = 740 MHz, L1 = 8.2 nH	[2]		7.5		dB
		f = 882 MHz, L1 = 8.2 nH	[3]	-	12.0	-	dB
		f = 943 MHz, L1 = 8.2 nH	[4]	-	13.0	-	dB
RLout	output return loss	f = 470 MHz, L1 = 18 nH		-	10	-	dB
		f = 650 MHz, L1 = 18 nH		-	20.5	-	dB
		f = 740 MHz, L1 = 18 nH	[2]	-	21.0	-	dB
		f = 740 MHz, L1 = 8.2 nH	[2]		21.0		dB
		f = 882 MHz, L1 = 8.2 nH	[3]	-	11.0	-	dB
		f = 943 MHz, L1 = 8.2 nH	[4]	-	10.0	-	dB
SL	isolation	f = 470 MHz, L1 = 18 nH		-	28.0	-	dB
		f = 650 MHz, L1 = 18 nH		-	24.0	-	dB
		f = 740 MHz, L1 = 18 nH	[2]	-	23.0	-	dB
		f = 740 MHz, L1 = 8.2 nH	[2]		23.0		dB
		f = 882 MHz, L1 = 8.2 nH	[3]	-	22.0	-	dB
		f = 943 MHz, L1 = 8.2 nH	[4]		21.5	-	dB
NF	noise figure	f = 470 MHz, L1 = 18 nH	[1] [6]	-	0.85	1.30	dB
		f = 650 MHz, L1 = 18 nH	[1] [6]	-	0.90	1.35	dB
		f = 740 MHz, L1 = 18 nH	[1] [2] [6]	-	0.95	1.40	dB
		f = 740 MHz, L1 = 8.2 nH	[1] [2] [6]		0.85	1.3	dB
		f = 882 MHz, L1 = 8.2 nH	[1] [3] [6]	-	0.85	1.3	dB
		f = 943 MHz, L1 = 8.2 nH	[1] [4] [6]	-	0.90	1.35	dB

## BGS8L2

### SiGe:C Low-noise amplifier MMIC with bypass switch for LTE

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
P <sub>i(1dB)</sub>	input power at 1 dB gain	f = 470 MHz, L1 = 18 nH	[1]	-13.0	-9.0	-	dBm
	compression	f = 650 MHz, L1 = 18 nH		-12.5	-8.5	-	dBm
				-11.0	-7.0	-	dBm
				-10.5	-7.5		dBm
		f = 882 MHz, L1 = 8.2 nH	] [3]	-10	-6.0	-	dBm
		f = 943 MHz, L1 = 8.2 nH	] [4]	-9.5	-5.5	-	dBm
IP3 <sub>i</sub>	input third-order intercept point	f = 470 MHz, L1 = 18 nH	[1]	-10.5	-5.5	-	dBm
		f = 650 MHz, L1 = 18 nH	[1]	-6	-1.0	-	dBm
		f = 740 MHz, L1 = 18 nH	] [2]	-5.5	-0.5	-	dBm
		f = 740 MHz, L1 = 8.2 nH	] [2]	-4.0	+1.0		dBm
		f = 882 MHz, L1 = 8.2 nH	] [3]	-4.0	+1.0	-	dBm
		f = 943 MHz, L1 = 8.2 nH	] [4]	-4.0	+1.0	-	dBm
К	Rollett stability factor			1	-	-	
t <sub>on</sub>	turn-on time	time from $V_{I(CTRL)}$ ON to 90 % of the gain		-	-	2.7	μs
t <sub>off</sub>	turn-off time	time from $V_{I(CTRL)}\text{OFF}$ to 10 % of the gain		-	-	0.6	μs

## **BGS8L2**

#### SiGe:C Low-noise amplifier MMIC with bypass switch for LTE

Symbol	Parameter	Conditions	r	Min	Тур	Max	Unit
Bypass m	ode						
lcc	supply current	V <sub>I(CTRL)</sub> < 0.3 V	-		-	1	μA
G <sub>p</sub>	power gain	f = 470 MHz, L1 = 18 nH	[1] -	3.0	-1.5	0.0	dB
		f = 650 MHz, L1 = 18 nH		4.0	-2.5	-1.0	dB
		f = 740 MHz, L1 = 18 nH	[1] [2] -		-3.0	-1.5	dB
		f = 740 MHz, L1 = 8.2 nH	[1] [2] -	3.1	-1.6	-0.1	dB
		f = 882 MHz, L1 = 8.2 nH	[3] -		-2.0	-0.5	dB
		f = 943 MHz, L1 = 8.2 nH	<sup>[1] [4]</sup> -	3.5	-2.0	-0.5	dB
RL <sub>in</sub>	input return loss	f = 470 MHz, L1 = 18 nH	-		13.0	-	dB
		f = 650 MHz, L1 = 18 nH	-		7.5	-	dB
		f = 740 MHz, L1 = 18 nH	[2] -		6.0	-	dB
		f = 740 MHz, L1 = 8.2 nH	[2] -		14.5	-	dB
		f = 882 MHz, L1 = 8.2 nH	[3] -	•	11.5	-	dB
		f = 943 MHz, L1 = 8.2 nH	<sup>[4]</sup> -		10.5	-	dB
RL <sub>out</sub>	output return loss	f = 470 MHz, L1 = 18 nH	-		12.0	-	dB
		f = 650 MHz, L1 = 18 nH	-		8.0	-	dB
		f = 740 MHz, L1 = 18 nH	[2] -		6.5	-	dB
		f = 740 MHz, L1 = 8.2 nH	[2] -		12.5	-	dB
		f = 882 MHz, L1 = 8.2 nH	[3] _		11.0	-	dB
		f = 943 MHz, L1 = 8.2 nH	[4] _		10.5	-	dB
Δφ	phase variation	between gain mode and bypass m	ode				
		f = 470 MHz, L1 = 18 nH	-		-	-	deg
		f = 650 MHz, L1 = 18 nH	-		-	-	deg
		f = 740 MHz, L1 = 18 nH	-		-	-	deg
		f = 740 MHz, L1 = 8.2 nH					deg
		f = 882 MHz, L1 = 8.2 nH	[1] _	5.0	-	+5.0	deg
		f = 943 MHz, L1 = 8.2 nH	-		-	-	deg

[1] [2] [3] [4] [5] [6]

Guaranteed by device design; not tested in production. E-UTRA operating band 17 (734 MHz to 746 MHz). E-UTRA operating band 5 (869 MHz to 894 MHz). E-UTRA operating band 8 (925 MHz to 960 MHz). RL<sub>in</sub> value can be increased by using a higher value for the series input matching inductor L1. PCB losses are subtracted.

#### Table 9. Characteristics at $V_{CC}$ = 2.8 V

460 MHz  $\leq f \leq$  960 MHz,  $V_{CC} = 2.8$  V,  $V_{I(CTRL)} \geq 0.8$  V and  $T_{amb} = 25$  °C. Input matched to 50  $\Omega$  using application diagram figure 3 and component values as in table 10.. Unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Gain mod	e						
I <sub>CC</sub>	supply current			3.2	5.2	7.2	mA
G <sub>p</sub>	power gain	f = 470 MHz, L1 = 18 nH	[1]	12.0	14.0	16.0	dB
		f = 650 MHz, L1 = 18 nH		13.0	15.0	17.0	dB
		f = 740 MHz, L1 = 18 nH		12.0	14.0	16.0	dB
		f = 740 MHz, L1 = 8.2 nH	[1] [2]	11.5	13.5	15.5	dB
		f = 882 MHz, L1 = 8.2 nH		11	13.0	15	dB
	f = 943 MHz, L1 = 8.2 nH	[1] [4]	10.5	12.5	14.5	dB	
RL <sub>in</sub>	input return loss	f = 470 MHz, L1 = 18 nH	[5]	-	4.5	-	dB
		f = 650 MHz, L1 = 18 nH		-	12.5	-	dB
		f = 740 MHz, L1 = 18 nH	[2]	-	11.5	-	dB
		f = 740 MHz, L1 = 8.2 nH	[2]	-	8.0	-	dB
		f = 882 MHz, L1 = 8.2 nH	[3]	-	12.0	-	dB
		f = 943 MHz, L1 = 8.2 nH	[4]	-	14.0	-	dB
RL <sub>out</sub>	output return loss	f = 470 MHz, L1 = 18 nH		-	9.5	-	dB
		f = 650 MHz, L1 = 18 nH		-	20.5	-	dB
		f = 740 MHz, L1 = 18 nH	[2]	-	20.0	-	dB
		f = 740 MHz, L1 = 8.2 nH	[2]	-	21.0	-	dB
		f = 882 MHz, L1 = 8.2 nH	[3]	-	12.5	-	dB
		f = 943 MHz, L1 = 8.2 nH	[4]	-	10.5	-	dB
ISL	isolation	f = 470 MHz, L1 = 18 nH		-	28.0	-	dB
		f = 650 MHz, L1 = 18 nH		-	24.0	-	dB
		f = 740 MHz, L1 = 18 nH	[2]	-	23.0	-	dB
		f = 740 MHz, L1 = 8.2 nH	[2]	-	23.0	-	dB
		f = 882 MHz, L1 = 8.2 nH	[3]	-	22.0	-	dB
		f = 943 MHz, L1 = 8.2 nH	[4]	-	21.5	-	dB
NF	noise figure	f = 470 MHz, L1 = 18 nH	[1] [6]	-	0.85	1.30	dB
		f = 650 MHz, L1 = 18 nH	[1] [6]	-	0.90	1.35	dB
		f = 740 MHz, L1 = 18 nH	[1] [2] [6]	-	0.95	1.40	dB
		f = 740 MHz, L1 = 8.2 nH	[1] [2] [6]	-	0.85	1.3	dB
		f = 882 MHz, L1 = 8.2 nH	[3] [6]	-	0.85	1.3	dB
		f = 943 MHz, L1 = 8.2 nH	[1] [4] [6]	-	0.85	1.3	dB

## BGS8L2

### SiGe:C Low-noise amplifier MMIC with bypass switch for LTE

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
P <sub>i(1dB)</sub>	input power at 1 dB gain	f = 470 MHz, L1 = 18 nH	[1]	-8.5	-4.5	-	dBm
	compression	f = 650 MHz, L1 = 18 nH	[1]	-7.5	-3.5	-	dBm
		f = 740 MHz, L1 = 18 nH	[1] [2]	-6.0	-2.0	-	dBm
		f = 740 MHz, L1 = 8.2 nH	[1] [2]	0.0	-2.0	-	dBm
		f = 882 MHz, L1 = 8.2 nH	[1] [3]	-5.0	-1.0	-	dBm
		f = 943 MHz, L1 = 8.2 nH	[1] [4]	-4.5	-0.5	-	dBm
IP3 <sub>i</sub>	input third-order intercept point	f = 470 MHz, L1 = 18 nH	[1]	-9.5	-4.5	-	dBm
		f = 650 MHz, L1 = 18 nH	[1]	-5	0.0	-	dBm
		f = 740 MHz, L1 = 18 nH	[1] [2]		+0.5	-	dBm
		f = 740 MHz, L1 = 8.2 nH	[1] [2]	-3.5	+1.5	-	dBm
		f = 882 MHz, L1 = 8.2 nH	[1] [3]	-3.5	+1.5	-	dBm
		f = 943 MHz, L1 = 8.2 nH	[1] [4]	-3.5	+1.5	-	dBm
К	Rollett stability factor			1	-	-	
t <sub>on</sub>	turn-on time	time from $V_{\text{I(CTRL)}}$ ON, to 90 % of the gain		-	-	2.1	μs
t <sub>off</sub>	turn-off time	time from $V_{I(CTRL)}\text{OFF},$ to 10 % of the gain		-	-	0.3	μs

## **BGS8L2**

#### SiGe:C Low-noise amplifier MMIC with bypass switch for LTE

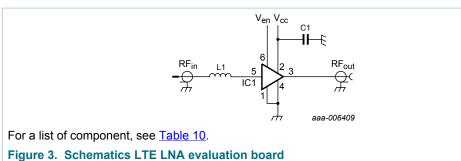
Symbol	Parameter	Conditions	M	lin	Тур	Max	Unit	
Bypass m	ode							
I <sub>CC</sub>	supply current	V <sub>I(CTRL)</sub> < 0.3 V	-		-	1	μA	
G <sub>p</sub>	power gain	f = 470 MHz, L1 = 18 nH	<sup>[1]</sup> -3	3.0	-1.5	0.0	dB	
		f = 650 MHz, L1 = 18 nH		4.0	-2.5	-1.0	dB	
		f = 740 MHz, L1 = 18 nH	[1] [2] _4		-3.0	-1.5	dB	
		f = 740 MHz, L1 = 8.2 nH	<sup>[1] [2]</sup> -3	3.1	-1.6	-0.1	dB	
		f = 882 MHz, L1 = 8.2 nH	<sup>[3]</sup> -3		-1.9	-0.4	dB	
		f = 943 MHz, L1 = 8.2 nH	<sup>[1] [4]</sup> -3	3.5	-2.0	-0.5	dB	
RL <sub>in</sub>	input return loss	f = 470 MHz, L1 = 18 nH	-		13.0	-	dB	
		f = 650 MHz, L1 = 18 nH	-		7.0	-	dB	
		f = 740 MHz, L1 = 18 nH	[2] _		5.5	-	dB	
		f = 740 MHz, L1 = 8.2 nH	[2] _		15.0	-	dB	
		f = 882 MHz, L1 = 8.2 nH	[3] _		11.5	-	dB	
		f = 943 MHz, L1 = 8.2 nH	[4] _		11.0	-	dB	
RL <sub>out</sub>	output return loss	f = 470 MHz, L1 = 18 nH	-		12.0	-	dB	
		f = 650 MHz, L1 = 18 nH	-		8.0	-	dB	
		f = 740 MHz, L1 = 18 nH	[2] _		6.5	-	dB	
		f = 740 MHz, L1 = 8.2 nH	[2] _		13.0	-		
		f = 882 MHz, L1 = 8.2 nH	[3] _		11.5	-	dB	
		f = 943 MHz, L1 = 8.2 nH	[4] _		11.5	-	dB	
Δφ	phase variation	between gain mode and bypass m	between gain mode and bypass mode					
		f = 470 MHz, L1 = 18 nH	-		-	-	deg	
		f = 650 MHz, L1 = 18 nH	-		-	-	deg	
		f = 740 MHz, L1 = 18 nH	-		-	-	deg	
		f = 740 MHz, L1 = 8.2 nH					deg	
		f = 882 MHz, L1 = 8.2 nH	<sup>[1]</sup> -5	5.0	-	+5.0	deg	
		f = 943 MHz, L1 = 8.2 nH	-		-	-	deg	

[1] [2] [3] [4] [5] [6]

Guaranteed by device design; not tested in production. E-UTRA operating band 17 (734 MHz to 746 MHz). E-UTRA operating band 5 (869 MHz to 894 MHz). E-UTRA operating band 8 (925 MHz to 960 MHz). RL<sub>in</sub> value can be increased by using a higher value for the series input matching inductor L1. PCB losses are subtracted.

## **13** Application information

### 13.1 LTE LNA

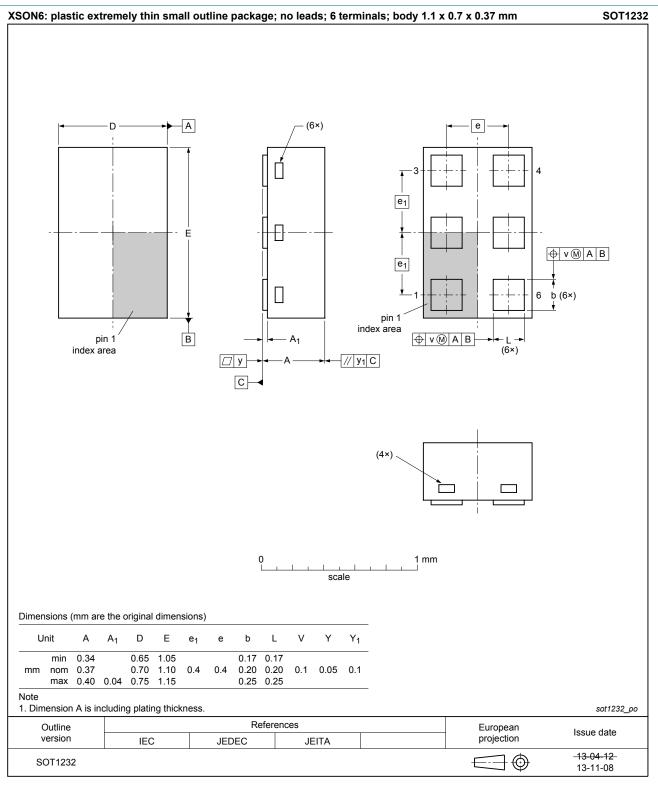


#### Table 10. List of components

For schematics see, Figure 3.

Component	Description	Value	Remarks
C1	decoupling capacitor	1 µF	to suppress power supply noise
IC1	BGS8L2	-	NXP Semiconductors N.V.
L1	high-quality matching inductor	18 nH	460 < f < 728 MHz Murata LQW15A
		8.2 nH	728 < f < 960 MHz Murata LQW15A

## 14 Package outline



#### Figure 4. Package outline SOT1232 (XSON6)

## **15 Handling information**

## CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices. Such precautions are described in the *ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A* or equivalent standards.

## **16 Abbreviations**

Table 11. Abbreviations			
Acronym	Description		
ESD	ElectroStatic Discharge		
НВМ	Human Body Model		
LTE	Long-Term Evolution		
MMIC	Monolithic Microwave Integrated Circuit		
PCB	Printed-Circuit Board		
SiGe:C	Silicon Germanium Carbon		

## **17 Revision history**

#### Table 12. Revision history

	mistory						
Document ID	Release date	Data sheet status	Change notice	Supersedes			
BGS8L2 v.6	20180629	product data sheet	-	BGS8L2 v.5			
Modifications:	changed V <sub>I(CTRL)</sub> M	changed $V_{I(CTRL)}$ Max ON state value to $V_{cc}$ at recommended operating conditions					
BGS8L2 v.5	20171116	product data sheet	-	BGS8L2 v.4			
Modifications:		onditions f = 470 MHz, f = 65 onditions f = 470 MHz, f = 65 value 18 nH					
BGS8L2 v.4	20170117	Product data sheet	-	BGS8L2 v.3			
Modifications:	• Section 1: added	<u>Section 1</u> : added LTE3001L according to our new naming convention					
BGS8L2 v.3	20160329	Product data sheet	-	BGS8L2 v.2			
Modifications:	Table 9 on page	5: added maximum value in 6: added minimum value in f 6: added maximum value in	Di(1dB)				
BGS8L2 v.2	20160316	Product data sheet	-	BGS8L2 v.1			
Modifications:	<ul> <li>added phase var</li> </ul>	added phase variation Table 8 on page 5 and Table 9 on page 6					
BGS8L2 v.1	20151221	Product data sheet	-	-			

## **18 Legal information**

#### 18.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

Please consult the most recently issued document before initiating or completing a design. [1]

The term 'short data sheet' is explained in section "Definitions".

[2] [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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BGS8L2 **Product data sheet** 

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## BGS8L2

#### SiGe:C Low-noise amplifier MMIC with bypass switch for LTE

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## BGS8L2

SiGe:C Low-noise amplifier MMIC with bypass switch for LTE

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